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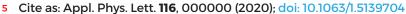
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Current induced chiral domain wall motion in Culr/CoFeB/MgO thin films with strong higher order spin-orbit torques



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ABSTRACT

- 18 We investigate the Dzyaloshinskii-Moriya interaction (DMI) and spin-orbit torque effects in CuIr/CoFeB/MgO heterostructures. To this end,
- 19 harmonic Hall measurements and current induced domain wall motion experiments are performed. The motion of domain walls at zero
- 20 applied field due to current demonstrates the presence of DMI in this system. We determine the strength of the DMI to be $D = +5 \pm 3 \mu J/m^2$
- and deduce right-handed chirality in domain walls showing a partial Néel type spin structure. To ascertain the torques, we perform a second
- harmonic measurement to quantify the damping- and field-like current induced effective fields as a function of the magnetization direction. From the angular dependent analysis, we identify non-negligible higher order terms for polar magnetization angles $\theta > 0$, which need to be
- included when considering the effective manipulation of spins by current.

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Research into materials suitable for spintronics is crucial to effectively utilize the spins of electrons as information carriers. One example of novel digital data storage concepts is the racetrack memory, which utilizes a series of magnetic domains that store the information and are separated by domain walls that can be moved by electrical currents. There have been observations of fast and synchronous domain wall motion in ultra-thin heterostructures with perpendicular 31 magnetic anisotropy (PMA), which consist of a ferromagnetic layer 33 (FM) sandwiched between a heavy metal (HM) and an oxide layer.² 34 These systems allow for the efficient manipulation of magnetization 35 due to their structural inversion asymmetry (SIA) combined with a 36 strong spin-orbit coupling. Both properties in combination lead to the generation of spin-orbit torques (SOTs) as well as the presence of the interfacial Dzyaloshinskii-Moriya interaction (DMI).5 that allow ultra-efficient and synchronous domain wall motion move the chiral domain walls stabilized by the DMI.^{3,4,8} In typical PMA systems, such as Pt/Co/AlOx^{2,9,10} and Ta/CoFeB/MgO,¹¹ the stabilization of Néel domain walls due to DMI, along with the efficient current induced control of the magnetization via SOTs, has been studied. Here, the inverse spin galvanic effect ^{12,13} and the spin Hall effect ^{14,15} are known to be responsible for SOTs.8 Recently, metallic alloy systems such as Au-W, 16 Au-Cu, 17 Au-Pt, 18 Cu-Bi, 19 Cu-Pb, 20 and Cu-Ir^{21,22} have shown large spin Hall effects, which implies efficient charge to spin conversion that can lead to large SOTs. Specifically, the alloy of Cu-Ir has been shown to exhibit a sizeable spin Hall angle (SHA), 21,22 which means that a large charge to spin conversion efficiency can be expected. Previous studies have found a temperature independent SHA in Ir doped Cu (for $T < 200\,\mathrm{K}$), the size of which was found to be 0.021 for an iridium concentration of 1%-12%.²¹ There have also been studies showing an efficient spin to current conversion in the iridium concentration range of \sim 40%. ²² However, there have not been studies on the current induced domain wall motion due to the SOTs or a quantification of them in these systems. Thus, in this work, using this composition with efficient spin to current conversion, we investigate domain wall motion in the material stack Cu₆₀Ir₄₀/ Co₂₀Fe₆₀B₂₀/MgO. From the current induced domain wall motion, we extract the strength of the DMI. In order to investigate the main driving force of such domain wall motion, we use second harmonic Hall

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measurements to provide a quantitative analysis of the SOTs in our system.

The thin $Cu_{60}Ir_{40}(5 \text{ nm})/Co_{20}Fe_{60}B_{20}(0.6 \text{ nm})/MgO(3 \text{ nm})/Ta(5 \text{ nm})$ film was deposited by magnetron sputtering (Singulus ROTARIS) onto a thermally oxidized silicon substrate. To obtain PMA, the film was annealed at 300 °C for 2 h at a pressure of 10⁻⁸ mbar. The magnetic properties were measured using a superconducting quantum interference device (SQUID) magnetometer. The measured anisotropy field and saturation magnetization are $\mu_0 H_k = 0.18 \pm 0.01 \,\mathrm{T}$ and $M_{\rm s}=5.7\pm0.2\times10^5{\rm A/m}$, respectively. Using electron-beam lithography, we pattern 30 microwires each having dimensions of $1 \,\mu\text{m} \times 30 \,\mu\text{m}$ with two pads at the ends of the wires [see Fig. 1(a) for the scheme of the domain wall velocity measurement]. For the second harmonic Hall measurement [see Fig. 2(a)], we pattern a Hall bar. The current induced domain wall motion experiment is performed at room temperature with a polar Kerr microscope using the differential contrast mode. To inject pulses into the microwires, we used a pulse generator and monitored the transmitted pulses using an oscilloscope, as illustrated in Fig. 1(a). To move the

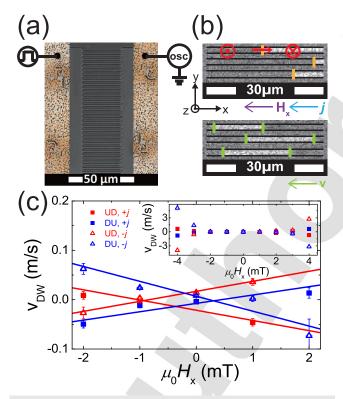


FIG. 1. (a) Microscope image of the microwires with the schematics of the setup for the domain wall (DW) motion. (b) Differential Kerr microscopy images of current induced DW motion at $H_x=-2\,\text{mT}$ before and afte<mark>r 5000</mark> current pulses with an amplitude of $j=-7.2\times10^{11}\,\text{A/m}^2$. Red symbols display the magnetization state. Gray refers to up and white to down magnetization. The orange lines indicate the location of the initialized DWs, and the green lines indicate the moved distance. (c) Current induced DW velocity as a function of the applied in-plane field H_x. The lines represent linear fits to the shown data points. The inset shows the same data with a larger in-plane field range from $-4\,\mathrm{mT}$ to $4\,\mathrm{mT}$. The experiment was done at room temperature. Red data refer to up-down (UD) DWs, and blue data to down-up (DU) DWs.

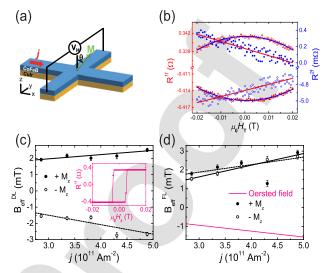


FIG. 2. (a) Schematic of the second harmonic measurement in a Hall bar geometry. (b) First (red) and second harmonic Hall resistances (blue) as a function of an external field along the transverse y-direction. Filled (empty) symbols display an initial magnetization configuration along the +z (-z) direction. The solid lines are the fit lines used for the analysis. (c), (d) DL and FL effective fields plotted vs the applied current density j. Solid (dashed) lines refer to a linear fit including the +z (-z) values. The inset in (c) shows the first harmonic Hall resistance as a function of an applied field along the z-direction. The pink line in (d) depicts the Oersted field. All data represented here are measured at room temperature.

nucleated domain walls, a series of either positive or negative current pulses is applied. The domain wall displacement is imaged via polar Kerr microscopy by subtracting a background image of the nucleated domain walls from the one after the current induced motion [for examples, see Fig. 1(b)]. Depending on the amplitude of the external in-plane field, a series of 20 ns current pulses was sent through the wires, ranging from 100 to 50 000. The ratio between the domain wall displacement and the total pulse time corresponds to a single domain wall velocity. For the analysis, we use the fact that the domain wall only moves during the pulse injection time. The injected current density when assumed to be distributed equally for all wires is calculated to be $j = \pm 7.2 \times 10^{11} \text{ A/m}^2$.

The SOTs were quantified by a second harmonic Hall measurement. 9,23,24 Since a temperature dependent analysis can reveal the mechanisms and origins of the SOTs, we measured the SOTs at T = 10 and 300 K. The SOTs were determined for different magnetization tilt angles θ by measuring different magnetic field ranges.

In Fig. 1(c), the in-plane field dependence of the average domain wall velocity $v_{\rm DW}$ with the corresponding standard error is displayed. We consider domain wall velocities for the cases when more than 50% of the initialized domain walls have moved since each domain wall has a different depinning originating from edge roughness and defects due 103 to the device fabrication. In Fig. 1(b), you can see an example of the 104 domain wall motion along the technical current direction, which is the 105 direction against the electron flow. This underlies the fact that we 106 move domain walls by SOTs, as spin-transfer torque would move walls 107 along the electron flow direction.²⁶ For the domain wall to be moved 108 by SOTs, a Néel component in the domain wall needs to be present.^{4,27} Thus, when the in-plane field compensates the Néel wall component, 110

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this marks the stopping field when the domain wall velocity is zero. 111 112 Accordingly, if DMI is present in our system, the stopping field is non-zero and independent of the current direction. For chiral 113 up-down and down-up domain walls, the sign is expected to be oppo-114 site, while the absolute values should be the same. The magnitude of 115 the DMI can be extracted from these stopping fields. In accordance to 116 a simple 1D model, we expect a linear relation between the domain 117 wall velocity and the applied in-plane field. 11 Therefore, in the field 118 range $-2 \,\mathrm{mT} \le \mu_0 H_\mathrm{x} \le 2 \,\mathrm{mT}$, we perform linear fits to determine 119 the value of the stopping field. This field matches the effective 120 DMI field $|\mu_0 H_{\rm DMI}|$. By averaging the absolute value of the two inter-121 section points for up-down and down-up domain walls, we obtain 122 $|\mu_0 H_{\rm DMI}| = 0.6 \pm 0.3 \,\mathrm{mT}$. This value leads to a DMI constant of 123 $D = 5 \pm 3 \,\mu J/m^2$ according to the relation $D = \mu_0 H_{DMI} M_s \Delta$, ²⁸ where 124 $\Delta = \sqrt{A/K_{\rm eff}}^{29}$ is the domain wall width, while A is the exchange 125 stiffness and $K_{\rm eff}=\mu_0 H_{\rm k} M_{\rm s}/2$ is the effective anisotropy constant 126 in line with the Stoner-Wohlfarth model.³⁰ We have used 127 $A = 10^{-11} J/m$ from the literature. For the larger field range, 128 $2 \text{ mT} \le |\mu_0 H_x|$ [see the inset of Fig. 1(c)], an increase in the domain 129 wall velocity can be observed. To estimate whether the domain walls 130 in our system are fully Néel-type, we calculate the critical DMI con-131 stant $D_c = 4\Delta K_{shape}/\pi = 34\mu J/m^{228}$ with the shape anisotropy K_{shape} 132 $= N_x \mu_0 M_s^2/2 = (\ln 2t_{\rm FM}/\pi \Delta) \mu_0 M_s^2/2^{32}$ relevant for the domain wall. 133 In order to calculate the shape anisotropy of the domain wall, one has to consider the demagnetization tensor component N_x. Here, the ratio between the thickness of the ferromagnetic layer t_{FM} and the domain wall width Δ is important. Since the measured DMI constant is smaller than the critical DMI value D < D_c, we expect a domain wall spin 139 configuration which is neither completely Néel nor fully Bloch. By observing a chiral nucleation of reversed domains,³³ we deduce righthanded chiral domain walls with a partly Néel configuration in our 142 system that corresponds to a positive DMI constant. A recent study of the DMI via Brillouin light scattering in the similar multilayer system 143 Ir/CoFeB/MgO has reported a positive DMI constant.³⁴ This agree-144 145 ment with our sign of the DMI constant indicates that the 5d-3d orbital hybridization³⁵ with the Ir atoms is the likely underlying mech-146 147 anism for an enhanced DMI.

Since the main driving force of the domain wall motion in the above measured system is SOT, we measured the SOTs via second harmonic Hall measurements. We determined the current induced effective fields generated by the field-like (FL) and damping-like (DL) torques. The first and second harmonic signals of the Hall voltage are measured, as shown in Fig. 2(a), while scanning the magnetic fields along the transverse (y), $H_{\rm T}$, and longitudinal (x), $H_{\rm L}$, directions. We are able to measure the FL and DL components of the SOT induced effective fields depending on the applied in-plane field direction. In the inset of Fig. 2(c), the magnetic hysteresis loop measured via the anomalous Hall effect is displayed, showing a square shape and thus indicating a strong PMA in the film.

Figure 2(b) shows the representative graphs of the first harmonic resistance, R^{1f} , and the second harmonic resistance, R^{2f} , signals when the in-plane field is applied along the transverse direction for a low inplane field range, where R^{1f} shows a quadratic and R^{2f} a linear behavior. In Figs. 2(c) and 2(d), we present the measured effective fields for small polar angles of the magnetization $\theta \ll 1^{\circ}.^{23,24}$ The applied inplane field range is chosen so that the magnetization tilt angle θ will

not exceed 1°, thus maintaining a single domain state. From the 167 relation, ²⁴

$$B_{\rm eff}^{\rm DL/FL} = -2 \frac{\left(B_{\rm L/T} \pm 2\xi B_{\rm T/L}\right)}{1 - 4\xi^2};$$
 (1)

we can extract the effective fields, where $\xi = R_{PHE}/R_{AHE}$ corresponds 169 to the ratio between the planar Hall resistance (R_{PHE}) and the anomalous Hall resistance (R_{AHE}), while $B_{L/T} = \left(\frac{\partial R^{2f}}{\partial H_{L/T}} / \frac{\partial^2 R^{1f}}{\partial^2 H_{L/T}}\right)\Big|_{\vec{H} \parallel \vec{x}/\vec{y}}$ consists of the first derivative of the second harmonic signal and the 172 second derivative of the first harmonic signal. The \pm sign corresponds 173 to the case when the magnetization is saturated in the $\pm z$ direction. 174 The dependencies of the extracted FL and DL effective fields on 175 the current density j are plotted in Figs. 2(c) and 2(d). As expected 176 from symmetry, the DL effective field is found to be odd with the 177 inversion of the magnetization, while the FL effective field is even.^{9,2} In order to evaluate the effective field per current density, a linear fit 179 was performed and the measured effective fields are found to be 180 $B_{\rm eff}^{DL} = 0.4 \pm 0.1 mT/10^{11} Am^{-2}$ and $B_{\rm eff}^{FL} = 0.5 \pm 0.2 mT/10^{11} Am^{-2}$. Since the BFL effective field is in the direction transverse to the applied 182 current, the contribution from the Oersted field induced by the applied 183 current needs to be taken into account. It was calculated to be 184 $\mu_0 H_{\text{Oe}} = -0.31 \,\text{mT}/10^{11} \text{Am}^{-224}$ and is illustrated as a pink line in 185 Fig. 2(d). As the Oersted field is opposite in direction to the FL effective 186 field, its absolute value has to be added to the measured B_{eff} value to 187 obtain the FL effective field $B_{\text{eff}}^{\text{FL}} = 0.8 \pm 0.2 \text{mT}/10^{11} \text{Am}^{-2}$ induced by 188 the SOTs.²⁴ At T = 10 K, we obtain $B_{\text{eff}}^{\text{DL}} = 1.58 \pm 0.02 \text{m} \text{T} / 10^{11} \text{Am}^{-2}$ 189 and $B_{\text{eff}}^{\text{FL}} = \frac{0.43 \pm 0.01 \text{mT}}{10^{11} \text{Am}^{-2}}$. Since the low temperature data 190 have a better signal-to-noise ratio than the high temperature data, we 191 observe different relative errors at two different temperatures. By 192 observing a decrease in the DL torque and an increase in the FL torque 193 with increasing temperature and thus different temperature dependences, we likely infer different origins for the torques. To compare our 195 results with the previously reported values of the SHA in CuIr films, we 196 calculate the effective SHA to be $\vartheta_{
m SH}={
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m FM}/\hbar^4$ assuming 197 that B_{eff} is solely due to the spin Hall effect and assuming transparent 198 interfaces between the CuIr and the CoFeB. Here, e is the electron 199 charge, $t_{\rm FM}$ is the thickness of the ferromagnetic layer, and \hbar is the 200 reduced Planck constant. At room temperature, we obtain $\vartheta_{\mathrm{SH}}^{\mathrm{300K}}$ $= 0.004 \pm 0.001$, while at 10 K, we extract $\vartheta_{\text{SH}}^{10\text{K}} = 0.0160 \pm 0.0006$. For 202 a low iridium concentration ranging from 1% to 12%, a temperature 203 independent value of 0.021 has been previously claimed from measure- 204 ments in a non-local spin valve geometry.²

Recently, an analysis showed that the angular dependence of the SOTs needs to be studied in order to understand the mechanism of how the current induced effective field can be applied in domain walls. Therefore, we have measured the polar angular dependence of the SOTs in our system. Figures 3(a) and 3(b) display the first and second harmonic Hall resistances for a larger field range $|\mu_0 H_{\rm L/T}| \leq 0.4\,{\rm T}$. Here, we apply the magnetic field with an out-of-plane tilt of $\theta=83^{\circ}$ to avoid multi-domain formation during the measurement. Accordingly, we apply an analysis method that is valid for an intermediate regime of the polar magnetization angle θ before the in-plane saturation state is reached. A full description of the analysis can be found in the supplementary material. In Fig. 3(c), the current induced effective field components are plotted vs the polar

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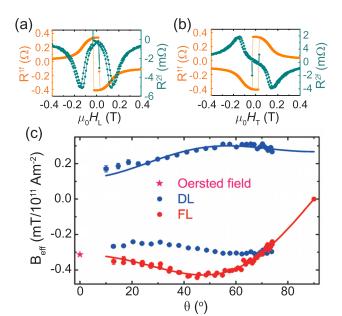


FIG. 3. (a) and (b) First and second harmonic Hall resistances as a function of the applied field along the longitudinal/transverse direction. (c) Current induced effective fields as a function of the polar magnetization angle measured at room temperature at a current density of $j = 2.86 \times 10^{11} \,\mathrm{A/m^2}$. The solid lines represent the fits to the measurement points in accordance with formulas (2) and (3).

magnetization angle θ measured at room temperature at a current density of $j = 2.86 \times 10^{11} \,\mathrm{A/m^2}$. For the FL component, one addi-220 tionally has to consider the Oersted field contribution that is depicted 221 by a pink star in Fig. 3(c). Within the intermediate θ model, the FL and DL effective fields can be described by the following formulas:

$$B_{\rm eff}^{\rm FL} = -{\rm cos}\theta \cdot \left(T_0^{\perp} + T_2^{\perp} \cdot {\rm sin}^2\theta + T_4^{\perp} \cdot {\rm sin}^4\theta\right), \tag{2}$$

$$\mathbf{B}_{\text{eff}}^{\text{DL}} = \left(\mathbf{T}_0^{\parallel} + \mathbf{T}_2^{\parallel} \cdot \sin^2 \theta + \mathbf{T}_4^{\parallel} \cdot \sin^4 \theta \right). \tag{3}$$

The solid lines in Fig. 3(c) represent the fits to the measurement points in accordance with formulas (2) and (3). By extracting the slope of these single fit parameters plotted against the current density j, we obtain the 227 general effective field parameters normalized to the current density. The FL torque parameters are $T_0^{\perp} = 0.09 \pm 0.03 \text{mT}/10^{11} \text{Am}^{-2}$, T_2^{\perp} $= 1.2 \pm 0.1 \text{mT}/10^{11} \text{Am}^{-2}$, and $T_4^{\perp} = -0.5 \pm 0.1 \text{mT}/10^{11} \text{Am}^{-2}$. For the DL torque, we extract $T_0^{\parallel} = 0.1 \pm 0.1 \text{mT} / 10^{11} \text{Am}^{-2}$, T_2^{\parallel} $= 0.5 \pm 0.4 \text{mT} / 10^{11} \text{Am}^{-2}$, and $T_4^{\parallel} = -0.4 \pm 0.3 \text{mT} / 10^{11} \text{Am}^{-2}$. By 232 considering both analysis methods, we obtain a full angular dependence of the current induced effective FL and DL components. Here, we note that the second and third higher order terms of the SOT are 235 very important in terms of magnitude compared to the first term. Thus, a careful analysis is required when using the measured SOT val-237 ues to understand the dynamics of the different parts of the spin texture 238 in a domain wall. From the description of Ref. 25, we calculated the 239 average effective SOT field acting on each spin in the DW by

$$B_{DL,FL}^{avg} = \frac{1}{\pi\lambda} \int \frac{B_{DL,FL}(\vartheta(x))}{\cosh\left(\frac{x-X}{\lambda}\right)} dx, \tag{4}$$

where $H_{DL,FL}(\vartheta(x))$ is the function of the angular dependence of the 240 effective field. From the equation, the calculated B_{DL}^{avg} and B_{FL}^{avg} are 241 0.19 \pm 0.06 mT/10¹¹Am⁻² and 0.09 \pm 0.02 mT/10¹¹Am⁻², respec-242 tively, which shows that the angular dependence needs to be taken into 243 account when considering the SOT effective fields acting on DWs.

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In conclusion, we observed the current induced domain wall 245 motion in the especially designed multilayer system CuIr/CoFeB/ 246 MgO. We choose the specific composition $Cu_{60}Ir_{40}$ with a high spin to 247 current conversion to obtain maximally large SOTs in combination 248 with PMA.²² Using this stack, we determined the DMI strength in our ²⁴⁹ system to be D = $+5.0\pm3\,\mu\text{J/m}^2$. The measured DMI value implies a 250 formation of partial Néel walls that are necessary for domain wall 251 motion by SOTs. Since the SOTs are the driving force to move domain 252 walls here, we extracted the FL and DL components of the SOTs by 253 the second harmonic Hall measurements. The measurement of the 254 SOTs in two different regimes demonstrates the presence of a strong 255 angular dependence of the torques on the magnetization direction. In 256 particular, our measurement reveals strong higher order terms of both 257 FL and DL torques that are often neglected but need to be taken into 258 account when calculating the SOTs acting on spin structures such as 259

See the supplementary material for the atomic force microscopy 262 measurements for the surface roughness information and calculations 263 for the angular dependent SOT measurements.

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